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Key indicators

Single-crystal X-ray study T = 293 KMean $\sigma(C-C) = 0.002 \text{ Å}$ R factor = 0.037 wR factor = 0.103 Data-to-parameter ratio = 13.7

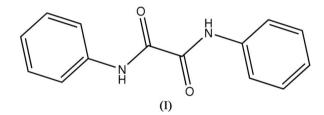
For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

N,N'-Diphenyloxalamide

The molecule of the title compound, $C_{14}H_{12}N_2O_2$, lies on a crystallographically imposed center of symmetry at the midpoint of the C–C bond of the oxalamide unit. Molecules are linked into ribbons along the *a* axis by N–H···O hydrogen bonds.

Comment

N,N'-Diphenyloxalamide and its derivatives have been widely applied in a number of materials as anti-oxidants, ultraviolet absorbents and/or metal ion passivators (Feng *et al.*, 1997). We report here the synthesis and structure of N,N'-diphenyloxalamide, (I) (Fig. 1 and Table 1).



The title compound has a crystallographically imposed center of symmetry at the mid-point of the C–C bond of the oxalamide unit. The bond lengths in the oxalamide unit show intermediate values due to π conjugation effects arising from the presence of the two C=O double bonds. All other bond lengths and angles are within normal ranges (Allen *et al.*, 1987). The molecule deviates somewhat from planarity, with the two O atoms twisted to opposite sides of the molecular plane, with a maximum deviation for O1 from the mean plane through C1–C7/N1 of 0.254 (4) Å. Intramolecular hydrogen bonds (C5–H5…O1) form six-membered rings between the phenyl rings and the carbonyl O atoms. In the crystal structure, molecules are linked into ribbons along the *a* axis (Fig. 2) by inversion-related intermolecular N–H···O hydrogen bonds (Table 2).

Experimental

To a solution of aniline (16.6 g, 0.2 mol) in benzene (90 ml) was added dropwise a solution of oxalyl chloride (6.4 g, 0.05 mol) in benzene (30 ml), and the mixture was stirred at 343 K for 6 h. After cooling to room temperature, 50 ml water was added and the organic phase was washed three times with water to give a white solid. The title compound was obtained after drying at room temperature for 48 h. Colorless single crystals suitable for X-ray diffraction were obtained by slow evaporation of an N,N-dimethylformamide solution over a period of 6 h.

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organic papers

Crystal data

 $\begin{array}{l} C_{14}H_{12}N_2O_2\\ M_r = 240.26\\ Monoclinic, P2_1/c\\ a = 5.3207 \ (7) \ Å\\ b = 5.3723 \ (7) \ Å\\ c = 20.5227 \ (19) \ Å\\ \beta = 101.437 \ (3)^\circ\\ V = 574.98 \ (12) \ Å^3 \end{array}$

Data collection

Siemens SMART 1000 CCD area detector diffractometer ω scans Absorption correction: multi-scan (*SADABS*; Sheldrick, 1996) $T_{min} = 0.960, T_{max} = 0.981$

Refinement

Refinement on F^2 $R[F^2 > 2\sigma(F^2)] = 0.037$ $wR(F^2) = 0.103$ S = 1.081133 reflections 83 parameters H-atom parameters constrained

Table 1

Selected	geometric	parameters	(A, '	°).
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O1-C7	1.2209 (14)	N1-C6	1.4182 (15)	
N1-C7	1.3366 (16)	C7-C7 ⁱ	1.543 (2)	
C7-N1-C6	127.27 (10)	$O1 - C7 - C7^{i}$	121.16 (13)	
O1-C7-N1	126.95 (11)	$N1 - C7 - C7^{i}$	111.89 (12)	

Symmetry code: (i) -x + 2, -y - 2, -z.

Table 2

Hydrogen-bond geometry (Å, °).

D-H	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdots A$
0.86	2.38	3.161 (1)	152
0.86	2.26	2.680(1)	110 116
	0.86 0.86	0.86 2.38	0.86 2.38 3.161 (1) 0.86 2.26 2.680 (1)

Symmetry codes: (i) -x + 2, -y - 2, -z; (ii) x - 1, y, z.

All H atoms were located in a difference Fourier map and constrained to ride on their parent atoms, with C-H = 0.93 Å, N-H = 0.86 Å and $U_{iso}(H) = 1.2U_{eq}(C,N)$.

Data collection: *SMART* (Siemens, 1996); cell refinement: *SAINT* (Siemens, 1996); data reduction: *SAINT*; program(s) used to solve structure: *SHELXTL* (Sheldrick, 1997); program(s) used to refine structure: *SHELXTL*; molecular graphics: *SHELXTL*; software used to prepare material for publication: *SHELXTL*, *PARST* (Nardelli, 1995) and *PLATON* (Spek, 2003).

Z = 2 $D_x = 1.388 \text{ Mg m}^{-3}$ Mo K\alpha radiation $\mu = 0.10 \text{ mm}^{-1}$ T = 293 (2) KBlock, colorless $0.43 \times 0.21 \times 0.20 \text{ mm}$

3076 measured reflections 1133 independent reflections 1039 reflections with $I > 2\sigma(I)$ $R_{\text{int}} = 0.019$ $\theta_{\text{max}} = 26.0^{\circ}$

$$\begin{split} &w = 1/[\sigma^2(F_o^2) + (0.0546P)^2 \\ &+ 0.089P] \\ &where \ P = (F_o^2 + 2F_c^2)/3 \\ (\Delta/\sigma)_{max} < 0.001 \\ \Delta\rho_{max} = 0.18 \ e^{\ A^{-3}} \\ \Delta\rho_{min} = -0.16 \ e^{\ A^{-3}} \\ Extinction \ correction: \ SHELXL97 \\ Extinction \ coefficient: \ 0.203 \ (17) \end{split}$$

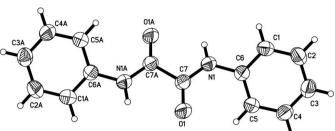


Figure 1

The structure of compound (I), showing 50% probability displacement ellipsoids and the atom-numbering scheme. Atoms labelled with the suffix 'A' are related to the other atoms by the symmetry code (2 - x, -2 - y, -z), corresponding to (i) in Table 1.

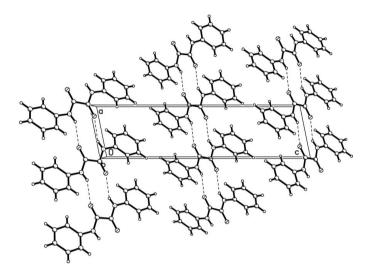


Figure 2

A view down the b axis, showing the ribbons generated by hydrogen bonds (indicated by dashed lines).

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